

<b>Notice of References Cited</b>	Application/Control No. 10/551,168		Applicant(s)/Patent Under Reexamination CHUNG ET AL.	
	Examiner Mark Kopec		Art Unit 1796	Page 1 of 1

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*	B	US-2008/0032062	02-2008	Meiere, Scott Houston	427/576
*	C	US-6,965,045	11-2005	Jung et al.	556/113
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#### NON-PATENT DOCUMENTS

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